# Trench Power MOSFET

## -20 V, Single P-Channel, SOT-23

#### **Features**

- Leading –20 V Trench for Low R<sub>DS(on)</sub>
- -1.8 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint
- NTRV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **Applications**

- Load/Power Management for Portables
- Load/Power Management for Computing
- Charging Circuits and Battery Protection

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage			V <sub>GS</sub>	±8.0	V
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.4	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		-1.7	
	t ≤ 10 s	T <sub>A</sub> = 25°C		-3.2	
Power Dissipation (Note 1)	Steady T <sub>A</sub> = 25°C State		P <sub>D</sub>	0.73	W
	t ≤ 10 s			1.25	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.8	Α
Current (Note 2)		T <sub>A</sub> = 85°C		-1.3	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.42	W
Pulsed Drain Current	tp = 10 μs		I <sub>DM</sub>	-18	Α
ESD Capability (Note 3)		100 pF, 1500 Ω	ESD	225	V
Operating Junction and Storage Temperature			T <sub>J</sub> ,	-55 to	°C
			T <sub>STG</sub>	150	
Source Current (Body Diode)			I <sub>S</sub>	-2.4	Α
Single Pulse Drain–to–Source Avalanche Energy ( $V_{GS}$ = -8 V, $I_L$ = -1.8 Apk, L = 10 mH, $R_G$ = 25 $\Omega$ )			EAS	16	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

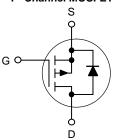


### ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
–20 V	70 mΩ @ –4.5 V	
	90 mΩ @ –2.5 V	-3.2 A
	112 mΩ @ –1.8 V	

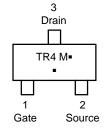
#### P-Channel MOSFET



# MARKING DIAGRAM & PIN ASSIGNMENT



SOT-23 CASE 318 STYLE 21



TR4 = Device Code
M = Date Code
Pb-Free Package

(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTR4101PT1G	SOT-23	3000 / Tape &
NTRV4101PT1G	(Pb-Free)	Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\theta JA}$	100	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	300	

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. ESD Rating Information: HBM Class 0

#### **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 4) $(V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A})$			-20			V
Zero Gate Voltage Drain Current (Note 4) (V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -16 V)		I <sub>DSS</sub>			-1.0	μΑ
Gate-to-Source Leakage Current (V <sub>GS</sub> = ±8.0 V, V <sub>DS</sub> = 0 V)					±100	nA
ON CHARACTERISTICS						•
Gate Threshold Voltage (Note 4) $(V_{GS} = V_{DS}, I_D = -250 \mu A)$		V <sub>GS(th)</sub>	-0.4	-0.72	-1.2	V
Drain-to-Source On-Resistance $(V_{GS} = -4.5 \text{ V}, I_D = -1.6 \text{ A})$ $(V_{GS} = -2.5 \text{ V}, I_D = -1.3 \text{ A})$ $(V_{GS} = -1.8 \text{ V}, I_D = -0.9 \text{ A})$				70 90 112	85 120 210	mΩ
Forward Transconductance ( $V_{DS} = -5.0 \text{ V}$ , $I_D = -2.3 \text{ A}$ )				7.5		S
CHARGES, CAPACITANCES & GA	TE RESISTANCE					
Input Capacitance		C <sub>iss</sub>		675		pF
Output Capacitance	$(V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = -10 \text{ V})$	C <sub>oss</sub>		100		
Reverse Transfer Capacitance		C <sub>rss</sub>		75		
Total Gate Charge	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q <sub>G(tot)</sub>		7.5	8.5	nC
Gate-to-Source Gate Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	$Q_{GS}$		1.2		nC
Gate-to-Drain "Miller" Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	$Q_{GD}$		2.2		nC
Gate Resistance		$R_{G}$		6.5		Ω
SWITCHING CHARACTERISTICS	(Note 5)					
Turn-On Delay Time		t <sub>d(on)</sub>		7.5		ns
Rise Time	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$	t <sub>r</sub>		12.6		
Turn-Off Delay Time	$I_D = -1.6 \text{ A}, R_G = 6.0 \Omega$	t <sub>d(off)</sub>		30.2		
Fall Time		t <sub>f</sub>		21.0		
DRAIN-SOURCE DIODE CHARAC	TERISTICS					
Forward Diode Voltage	$(V_{GS} = 0 \text{ V}, I_{S} = -2.4 \text{ A})$	V <sub>SD</sub>		-0.82	-1.2	V
Reverse Recovery Time		t <sub>rr</sub>		12.8	15	ns
Charge Time	$(V_{GS} = 0 \text{ V},$ $dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, I_{S} = -1.6 \text{ A})$	ta		9.9		ns
Discharge Time	]	t <sub>b</sub>		3.0		ns
Reverse Recovery Charge	Q <sub>rr</sub>		1008		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 5. Switching characteristics are independent of operating junction temperature.

#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

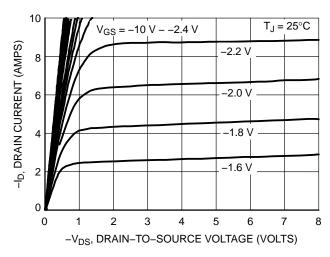


Figure 1. On-Region Characteristics

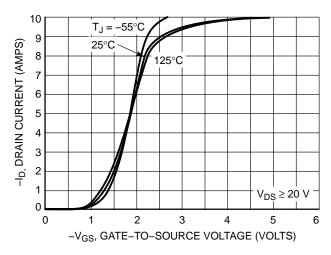


Figure 2. Transfer Characteristics

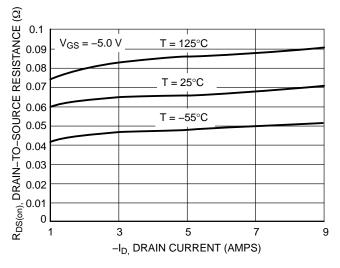


Figure 3. On–Resistance vs. Drain Current and Temperature

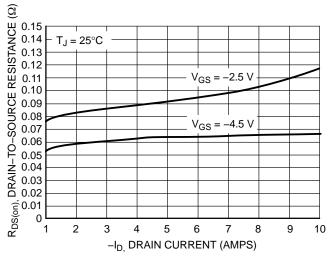


Figure 4. On–Resistance vs. Drain Current and Temperature

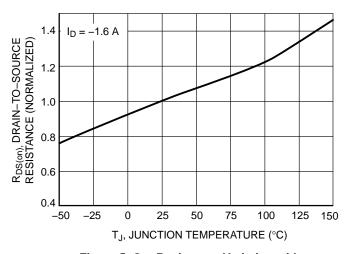


Figure 5. On–Resistance Variation with Temperature

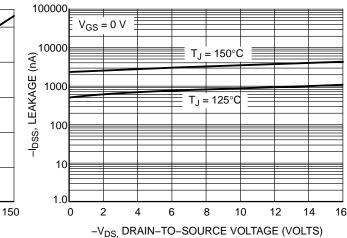


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}C$ unless otherwise noted)

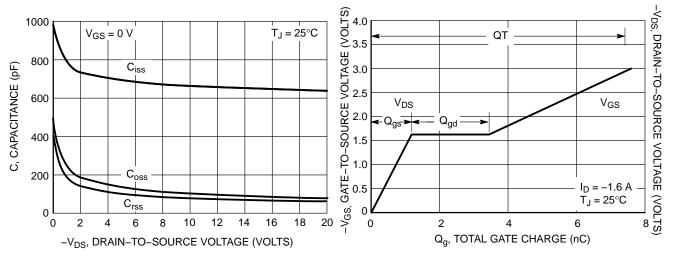


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Gate Charge

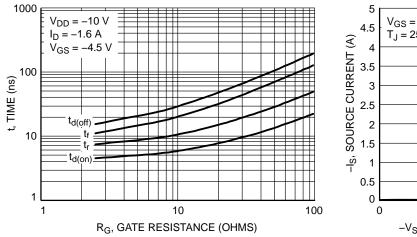


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

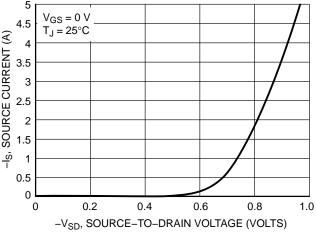


Figure 10. Diode Forward Voltage vs. Current

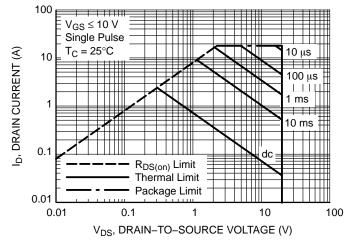
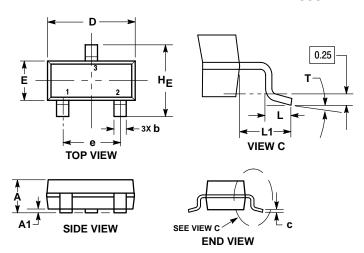


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### PACKAGE DIMENSIONS

#### SOT-23 (TO-236) CASE 318-08 **ISSUE AR**



#### NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
   MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH.
   MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL. I. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS.

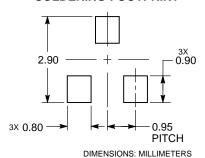
	MILLIMETERS				INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX		
Α	0.89	1.00	1.11	0.035	0.039	0.044		
A1	0.01	0.06	0.10	0.000	0.002	0.004		
b	0.37	0.44	0.50	0.015	0.017	0.020		
С	0.08	0.14	0.20	0.003	0.006	0.008		
D	2.80	2.90	3.04	0.110	0.114	0.120		
E	1.20	1.30	1.40	0.047	0.051	0.055		
е	1.78	1.90	2.04	0.070	0.075	0.080		
L	0.30	0.43	0.55	0.012	0.017	0.022		
L1	0.35	0.54	0.69	0.014	0.021	0.027		
HE	2.10	2.40	2.64	0.083	0.094	0.104		
T	0°		10°	0°		10°		

#### STYLE 12:

- PIN 1. CATHODE 2. CATHODE

  - 3. ANODE

#### RECOMMENDED SOLDERING FOOTPRINT



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